

**Search Notes**

Application/Control No.

10/773,784

Examiner

Steve Nguyen

Applicant(s)/Patent under  
Reexamination

WHETSEL, LEE D.

Art Unit

2133

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT; USOCR)	5/25/2005	SN